TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VCX74FT, TC74VCX74FK

Low-Voltage Dual D-Type Flip-Flop with 3.6-V Tolerant Inputs and Outputs

The TC74VCX74FT/FK is a high-performance CMOS D-type flip-flop which is guaranteed to operate from 1.2-V to 3.6-V. Designed for use in 1.5V, 1.8V, 2.5V or 3.3V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

It is also designed with overvoltage tolerant inputs and outputs up to $3.6\ V.$

The signal level applied to the D INPUT is transferred to Q $\frac{OUTPUT}{CLR} \frac{during}{during} \ the \ positive \ going \ transition \ of the \ CK \ pulse.$ CLR and $\overline{PR} \ are \ independent \ of \ the \ CK \ and \ are \ accomplished \ by \ setting \ the \ appropriate \ input \ low.$

All inputs are equipped with protection circuits against static discharge.

Features

- Low-voltage operation: VCC = 1.2 to 3.6 V
- High-speed operation: $t_{pd} = 3.5 \text{ ns (max)} (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$

 $: t_{pd} = 4.6 \text{ ns (max) (V}_{CC} = 2.3 \text{ to } 2.7 \text{ V})$

 $t_{pd} = 9.2 \text{ ns (max) (V}_{CC} = 1.65 \text{ to } 1.95 \text{ V}$

 $t_{pd} = 18.4 \text{ ns (max)} (V_{CC} = 1.4 \text{ to } 1.6 \text{ V})$

 $t_{pd} = 46.0 \text{ns} \text{ (max) (V}_{CC} = 1.2 \text{ V)}$

Output current: I_{OH}/I_{OL} = ±24 mA (min) (V_{CC} = 3.0 V)

 $: I_{OH}/I_{OL} = \pm 18 \text{ mA (min) (V}_{CC} = 2.3 \text{ V)}$

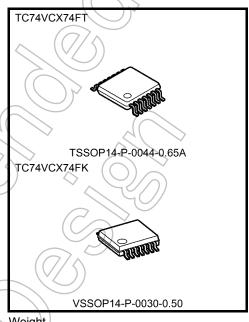
 $: I_{OH}/I_{OL} = \pm 6 \text{ mA (min)} (V_{CC} = 1.65 \text{ V})$

 $: I_{OH}/I_{OL} = \pm 2 \text{ mA (min)} (V_{CC} = 1.4 \text{ V})$

- Latch-up performance: -300 mA
- ESD performance: Machine model $\geq \pm 200 \text{ V}$

Human body model ≥ ±2000 V

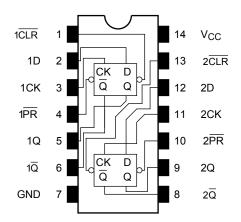
- Package: TSSOP and VSSOP (US)
- Power-down protection provided on all inputs and outputs



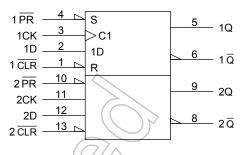
Weight

TSSOP14-P-0044-0.65A : 0.06 g (typ.) VSSOP14-P-0030-0.50 : 0.02 g (typ.)

Pin Assignment (top view)



IEC Logic Symbol



Truth Table

Function	puts	Out	Inputs				
T diletion	Q	Q	CK	D	PR	CLR	
Clear	Н	L	Х	Х	Н	L	
Preset	L	Н	Х	Х	L	Н	
- 4(Н	Н	Х	Х	L	L	
-	Н	L		L	Н	Н	
	L	Н		Н	Н	Н	
No change	Qn	Qn	\Box	Х	Н	Н	
		•	•		•		

X: Don't care

Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	7/Xcc	-0.5 to 4.6	V
DC input voltage	VIN	-0.5 to 4.6	٧
DC output voltage	Vout	-0.5 to 4.6 (Note 2) -0.5 to V _{CC} + 0.5 (Note 3)	٧
Input diode current	I _{IK}	-50	mA
Output diode current	lok	±50 (Note 4)	mA
DC output current	lout	±50	mA
Power dissipation	PD	180	mW
DC V _{CC} /ground current	ICC/IGND	±100	mA
Storage temperature	T _{stg}	-65~150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: $V_{CC} = 0 V$

Note 3: High or low state. I_{OUT} absolute maximum rating must be observed.

Note 4: $V_{OUT} < GND$, $V_{OUT} > V_{CC}$

Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V _{CC}	1.2 to 3.6	V
Input voltage	V _{IN}	-0.3 to 3.6	V
Output voltage	V	0 to 3.6 (Note 2)	V
Output voltage	V _{OUT}	0 to V _{CC} (Note 3)	V
		±24 (Note 4)	
Output current	I _{OH} /I _{OL}	±18 (Note 5)	
Output current		±6 (Note 6)	mA (
		±2 (Note 7)	
Operating temperature	T _{opr}	-40 to 85	(00)
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device: Unused inputs must be tied to either V_{CC} or GND.

Note 2: $V_{CC} = 0 V$

Note 3: High or low state

Note 4: $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$

Note 5: $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$

Note 6: $V_{CC} = 1.65 \text{ to } 1.95 \text{ V}$

Note 7: $V_{CC} = 1.4 \text{ to } 1.6 \text{ V}$

Note 8: $V_{IN} = 0.8$ to 2.0 V, $V_{CC} = 3.0$ V

Electrical Characteristics

DC Characteristics (Ta = -40 to 85°C, 2.7 V < V_{CC} \le 3.6 V)

Characteristics		Symbol	Test Condition		V _{CC} (V)	Min	Max	Unit
	H-level	VIH) (07	,	2.7 to 3.6	2.0	_	.,
Input voltage	L-level	VIL		2)	2.7 to 3.6	_	0.8	V
		\supset		Ι _{ΟΗ} = -100 μΑ	2.7 to 3.6	V _{CC} - 0.2	_	
	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -12 mA	2.7	2.2	_	
Z			\wedge	$I_{OH} = -18 \text{ mA}$	3.0	2.4	_	
Output voltage			9	$I_{OH} = -24 \text{ mA}$	3.0	2.2	_	V
		Vol	May Or Viv	$I_{OL} = 100 \mu A$	2.7 to 3.6	_	0.2	
	L-level			I _{OL} = 12 mA	2.7	_	0.4	
	L-level		V _{IN} ≠ V _{IH} or V _{IL}	$I_{OL} = 18 \text{ mA}$	3.0	_	0.4	
				I _{OL} = 24 mA	3.0	_	0.55	
Input leakage currer	nt	I _{IN}	V _{IN} = 0 to 3.6 V		2.7 to 3.6	_	±5.0	μА
Power off leakage co	urrent	l _{OFF}	V_{IN} , $V_{OUT} = 0$ to 3.6 V		0	_	10.0	μА
Quiescent supply current		laa	V _{IN} = V _{CC} or GND		2.7 to 3.6	_	20.0	
		Icc	V _{CC} ≤ V _{IN} ≤ 3.6 V		2.7 to 3.6	_	±20.0	μΑ
Increase in I _{CC} per i	nput	Δlcc	V _{IH} = V _{CC} - 0.6 V		2.7 to 3.6	_	750	

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DC Characteristics (Ta = -40 to 85°C, 2.3 V \leq V_{CC} \leq 2.7 V)

Characteris	stics	Symbol	Test Cor	ndition		Min	Max	Unit
					V _{CC} (V)			
Input voltage	H-level	V _{IH}	_	-	2.3 to 2.7	1.6	_	V
input voitage	L-level	V _{IL}	_	-	2.3 to 2.7		0.7	V
			$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -100 \mu A$	2.3 to 2.7	V _{CC} - 0.2		
	H-level	VoH		I _{OH} = -6 mA	2.3	2.0	_	
				I _{OH} = -12 mA	2.3	1.8		
Output voltage				$I_{OH} = -18 \text{ mA}$	2.3	1.7	_	V
				I _{OL} = 100 μA	2.3 to 2.7		0.2	
	L-level	V _{OL}	$V_{IN} = V_{IH}$ or V_{IL}	I _{OL} = 12 mA	2.3		0.4	
				I _{OL} = 18 mA	2.3		0.6	
Input leakage curre	nt	I _{IN}	$V_{IN} = 0 \text{ to } 3.6 \text{ V}$		2.3 to 2.7	17.	±5.0	μΑ
Power-off leakage of	ge current I _{OFF} V _{IN} , V _{OUT} = 0 to 3.6 V		0	7	10.0	μΑ		
Quiescent supply cu	ırrent	loo	$V_{IN} = V_{CC}$ or GND		2.3 to 2.7	14	20.0	Δ
Quiescent supply co	an ent	ICC	$V_{CC} \le V_{IN} \le 3.6 \text{ V}$		2.3 to 2.7		±20.0	μА

DC Characteristics (Ta = -40 to 85° C, 1.65 V \leq V_{CC} < 2.3 V)

Characteris	stics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}		1.65 to 2.3	0.65 × V _{CC}	_	V
	L-level	VIL (1.65 to 2.3	_	0.2 × V _{CC}	V
	H-level	VoH	V _{IN} = V _{IH} or V _{IL}	1.65 to 2.3	V _{CC} - 0.2		
Output voltage		1	l _{OH} = −6 mA	1.65	1.25	_	V
	L-level	V _{OL}	$V_{IN} = V_{IH}$ or V_{IL} $I_{OL} = 100 \mu A$	1.65 to 2.3	_	0.2	
	L-level	VOL	I _{OL} = 6 mA	1.65	_	0.3	
Input leakage currer	nt	\supset_{IIN}	V _{IN} = 0 to 3.6 V	1.65 to 2.3	_	±5.0	μА
Power-off leakage current		loff	V _{IN} , V _{OUT} = 0 to 3.6 V	0	_	10.0	μА
Outros and a complete and a		loo	V _{IN} = V _{CC} or GND	1.65 to 2.3	_	20.0	^
Quiescent supply cu	inelii	Icc	V _{CC} ≤ V _{IN} ≤ 3.6 V	1.65 to 2.3	_	±20.0	μΑ

DC Characteristics (Ta = -40 to 85° C, 1.4 V \leq V_{CC} < 1.65 V)

Characteri	stics	Symbol	Test Condition		V _{CC} (V)	Min	Max	Unit		
Input voltage	H-level	V _{IH}	_		1.4 to 1.65	0.65 × V _{CC}		V		
Input voltage L	L-level	V _{IL}	_		1.4 to 1.65	_	0.05 × V _{CC}	V		
	H-lev	H-level	V _{OH} V	level V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.4 to 1.65	VCC - 0.2		
Output voltage				I _{OH} = -2 mA	71.4	1.05	_	V		
	L-level	I level V	V _{IN} = V _{IH} or V _{IL}	$I_{OL} = 100 \mu A$	1.4 to 1.65		0.05			
	L-level	V _{OL}		I _{OL} = 2 mA	1.4		0.35			
Input leakage curre	nt	I _{IN}	$V_{IN} = 0$ to 3.6 V		1.4 to 1.65		±5.0	μΑ		
Power-off leakage of	ower-off leakage current I _{OFF} V _{IN} , V _{OUT} = 0 to 3.6 V			0	4	10.0	μΑ			
Quiescent supply of	Quiescent supply current		$V_{IN} = V_{CC}$ or GND		1.4 to 1.65	17	20.0	μА		
Quiescent supply co			$V_{CC} \le V_{IN} \le 3.6 \text{ V}$	(7/4)	1.4 to 1.65	2	±20.0	μΑ		

DC Characteristics (Ta = -40 to 85°C, 1.2 V \leq V_{CC} < 1.4 V)

Characteris	stics	Symbol	Test Condition		V _{CC} (V)	Min	Max	Unit
Innut voltage	H-level	V _{IH}			1.2 to 1.4	0.8 × V _{CC}		V
Input voltage	L-level	V _{IL}			1.2 to 1.4	l	0.05 × V _{CC}	V
Output voltage	H-level	VoH (VIN = VIH or VIL	I _{OH} = -100 μA	1.2	V _{CC} - 0.1		V
	L-level	VoL	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	1.2	_	0.05	
Input leakage currer	nt	(I _{IN} //	V _{IN} = 0 to 3.6 V	3	1.2		±5.0	μΑ
Power-off leakage c	Power-off leakage current IOFF VIN, VOUT = 0 to 3.6 V		\wedge	0	_	10.0	μΑ	
Quiescent supply current		loo	V _{IN} = V _{CC} or GND		1.2	_	20.0	μА
Quiescent supply cu	illelit.	lcc	$V_{CC} \le V_{IN} \le 3.6 \text{ V}$		1.2	_	±20.0	μА

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AC Characteristics (Ta = -40 to 85° C, input: $t_r = t_f = 2.0$ ns) (Note)

Characteristics	Symbol	Test 0	Condition	V _{CC} (V)	Min	Max	Unit
			C: 15 pC D: 2 kO	1.2	40	_	
			$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.5 ± 0.1	80	_	MHz
Maximum clock frequency	f _{max}	Figure 1, Figure 2		1.8 ± 0.15	100	_	
			$C_L = 30 \text{ pF}, R_L = 500 \Omega$	2.5 ± 0.2	200	_	
				3.3 ± 0.3	250	_	
				(/1.2)	3.0	46.0	
Propagation delay time $(CK\text{-}Q,\overline{\overline{Q}}\)$			$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.5 ± 0.1	2.0	18.4	
	t _{pLH}	Figure 1, Figure 2		1.8 ± 0.15	1.5	9.2	ns
	t _{pHL}		$C_L = 30 \text{ pF}, R_L = 500 \Omega$	2.5 ± 0.2	0.8	4.6	
			4(>>	3.3 ± 0.3	0.6	3.5	
				1.2	3.0	46.0	
			$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.5 ± 0.1	2.0	18.4	
Propagation delay time	t _{pLH}	Figure 1, Figure 4		1.8 ± 0.15	(1,5)	9.2	ns
$(\overline{CLR},\overline{PR}-Q,\overline{Q})$	t _{pHL}	($C_L = 30 \text{ pF}, R_L = 500 \Omega$	2.5 ± 0.2	0.8	4.6	
				3.3 ± 0.3	0.6	3.5	
			0; 45 = D; 210	1.2	24	_	ns
			$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.5 ± 0.1	8.0	_	
Minimum pulse width	t _W (H)	Figure 1, Figure 2		1.8 ± 0.15	4.0	_	
(CK)	t _W (L)		$C_L = 30 \text{ pF}, R_L = 500 \Omega$	2.5 ± 0.2	1.5	_	
				3.3 ± 0.3	1.5	_	
			O. 45 E. D. 210	1.2	24	_	
N.C. Company of the control of the			$C_L = 15 pF, R_L = 2 k\Omega$	1.5 ± 0.1	8.0	_	ns
Minimum pulse width (CLR, PR)	t _W (L) Figure	Figure 1, Figure 4		1.8 ± 0.15	4.0	_	
(CLK,PK)))	$C_L = 30 \text{ pF}, R_L = 500 \Omega$	2.5 ± 0.2	1.5	_	
			()	3.3 ± 0.3	1.5	_	
			C: 15 pE D: 2 kO	1.2	20	_	
			$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.5 ± 0.1	7.5	_	
Minimum set-up time	ts	Figure 1, Figure 2		1.8 ± 0.15	3.0	_	ns
		\wedge	$C_L = 30 \text{ pF}, R_L = 500 \Omega$	2.5 ± 0.2	1.5		
		4		3.3 ± 0.3	1.5		
	_ ($C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	8.0	_	
			σ _L = 10 pr , 1\(\(\frac{1}{2}\) = 2 \(\frac{1}{2}\)	1.5 ± 0.1	3.0	_	
Minimum hold time	th	Figure 1, Figure 2		1.8 ± 0.15	1.0		ns
	, //	\supset	$C_L = 30 \text{ pF}, R_L = 500 \Omega$	2.5 ± 0.2	1.0	_	
				3.3 ± 0.3	1.0	_	
			$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	24	_	ns
		Figure 1, Figure 3	OL 10 pr , M = 2 1022	1.5 ± 0.1	8.0	_	
Minimum removal time	al time trem F		$C_L = 30 \text{ pF}, R_L = 500 \Omega$	1.8 ± 0.15	3.0	_	
				2.5 ± 0.2	2.0	_	
					1.5	_	

Note: For $C_L = 50$ pF, add approximately 300 ps to the AC maximum specification.

Dynamic Switching Characteristics (Ta = 25°C, input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF)

Characteristics	Symbol	Test Condition		Тур.	Unit	
				V _{CC} (V)		
		V _{IH} = 1.8 V, V _{IL} = 0 V	(Note)	1.8	0.25	
Quiet output maximum dynamic V _{OL}	V _{OLP}	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	2.5	0.6	V
		V _{IH} = 3.3 V, V _{IL} = 0 V	(Note)	3.3	8.0	
	V _{OLV}	V _{IH} = 1.8 V, V _{IL} = 0 V	(Note)	1.8	-0.25	V
Quiet output minimum dynamic V _{OL}		$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	2.5	-0.6	
		V _{IH} = 3.3 V, V _{IL} = 0 V	(Note)	3.3	-0.8	
		V _{IH} = 1.8 V, V _{IL} = 0 V	(Nøte)	1.8	1.5	
Quiet output minimum dynamic V _{OH}		V _{IH} = 2.5 V, V _{IL} = 0 V	(Note)	2.5	1.9	V
		V _{IH} = 3.3 V, V _{IL} = 0 V	(Note)	3.3	2.2	

Note: Parameter guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition		V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}			1.8, 2.5, 3.3	6	pF
Power dissipation capacitance	C_{PD}	f _{IN} = 10 MHz	(Note)	1.8, 2.5, 3.3	20	pF

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

조

Measure

Average operating current can be obtained by the equation:

Output o

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2 (per F/F)$

AC Test Circuit

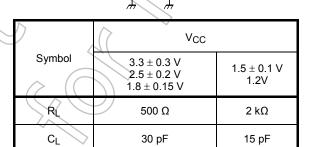
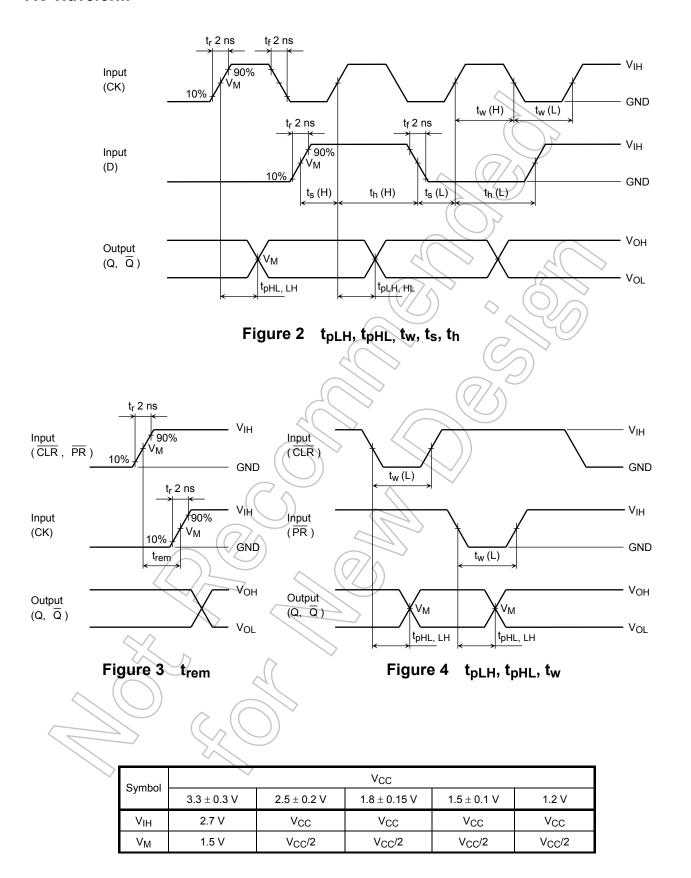


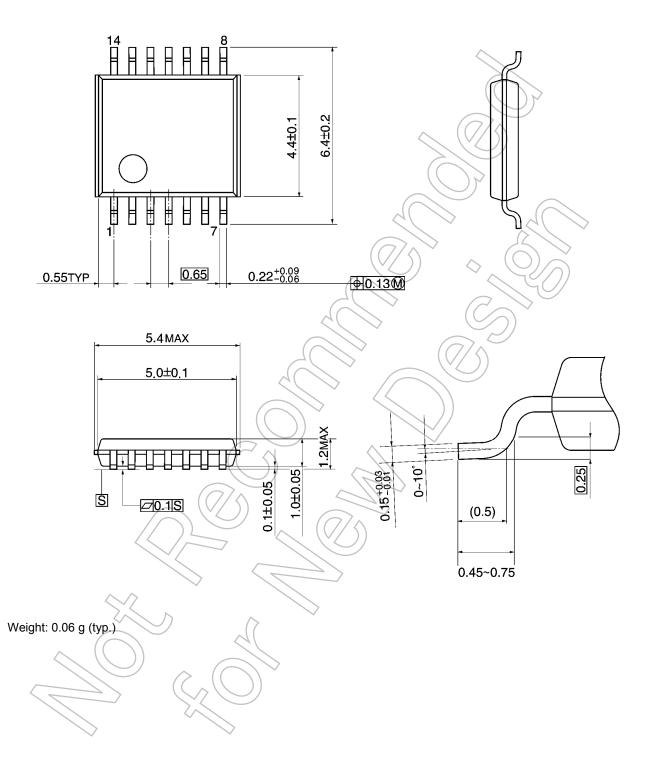
Figure 1

AC Waveform



Package Dimensions

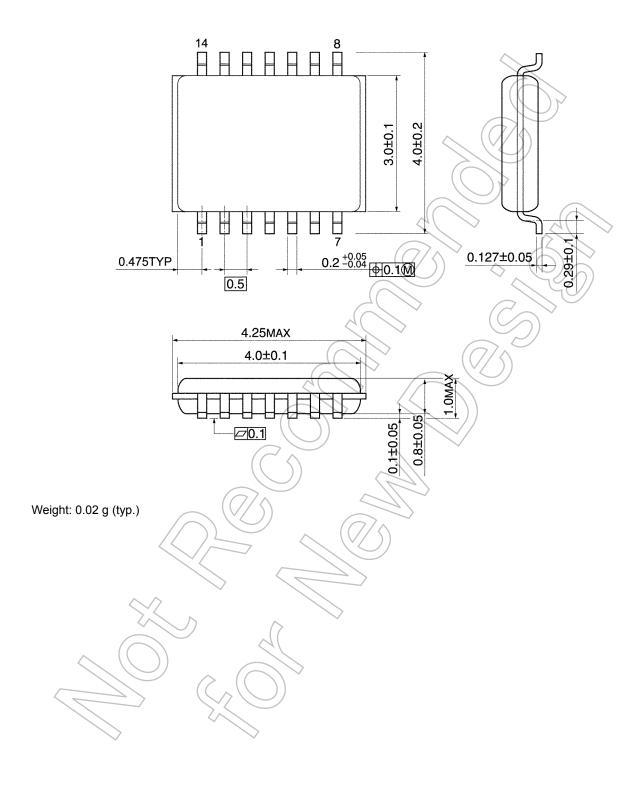
TSSOP14-P-0044-0.65A Unit: mm



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Package Dimensions

VSSOP14-P-0030-0.50 Unit: mm



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